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The Composition of Poly(Ethylene Terephthalate) (PET) Surface Precipitates Determined at High Resolving Power by Tandem Mass Spectrometry Imaging

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Abstract: We present the first demonstration of a general method for the chemical characterization of small surface features at high magnification via simultaneous collection of mass spectrometry (MS) imaging and tandem MS imaging data. High lateral resolution tandem secondary ion MS imaging is employed to determine the composition of surface features on poly(ethylene terephthalate) (PET) that precipitate during heat treatment. The surface features, probed at a lateral resolving power of <200 nm using a surface-sensitive ion beam, are found to be comprised of ethylene terephthalate trimer at a greater abundance than is observed in the surrounding polymer matrix. This is the first chemical identification of PET surface precipitates made without either an extraction step or the use of a reference material. The new capability employed for this study achieves the highest practical lateral resolution ever reported for tandem MS imaging.

Key words: mass spectrometry imaging, tandem MS imaging, molecular identification, polymer surface analysis, TOF-SIMS

INTRODUCTION

There is a body of published work spanning some 34 years concerning the identification of precipitates formed at the surface of thermally treated poly(ethylene terephthalate) (PET) (Perovik & Sundararajan, 1982; Briggs, 1986; Reichlmeier et al., 1995). This collection of work leads the reader to *infer* that the surface precipitates are comprised of crystalline ethylene terephthalate trimer. In this article we demonstrate that, with a single high spatial resolution analysis simultaneously collecting both mass spectrometry (MS¹) imaging data and tandem mass spectrometry (MS²) imaging data, one can directly *deduce* the chemical composition of the surface precipitates on heat-treated PET. This new method of molecular imaging and identification is broadly applicable in fields of medicine and pathology, performance materials, forensics, food science, pharmaceuticals, geology, electronic materials, power storage, and failure analysis. We establish, in the present study, a rapid method of molecular imaging and identification for use in such fields of investigation.

The treatment or modification of polymers has been of interest for many decades. The selected alterations serve to vary the friction and wear characteristics, chemical resistance, strength, hardness, and toughness of the affected polymer. Polymers used in various applications are commonly subject to thermal cycling which may induce additive blooming as well as changes in tacticity, morphology, and phase composition. PET is one of the most widely used polymers for food packaging

owing to global health safety approval and sustainability (Yates, 2000; Achilias & Karayannidis, 2004). PET is also one of the most common polymers used in the textile industry (Perovik & Sundararajan, 1982; Wolf, 2010). The outcome of modifications to a textile or food packaging polymer are of concern because of the relationship between the surface properties and, e.g., permeability, dyeability or printability, adhesion, and metallization (Parvinzadeh Gashti et al., 2011; Rudolf et al., 2012).

The first comprehensive reporting of thermally induced precipitates on the surface of PET was made by Perovik and Sundararajan in 1982 with the use of secondary electron microscope (SEM) imaging. Their chemical characterization involved a solvent extraction of a film specimen followed by nuclear magnetic resonance analysis of the evaporation residue. They reported that the features observed by SEM were comprised of cyclic ethylene terephthalate trimer. However, a vulnerability of a solvent extraction is that differences in surface and bulk chemistry will be lost. The first reported use of a surface-sensitive analytical technique to characterize heat-treated PET films made use of secondary ion mass spectrometry (SIMS) (Briggs, 1986). A purified specimen of pressed cyclic ethylene terephthalate trimer was used to collect a reference spectrum for comparison with the spectra of heat-treated PET films. The purified specimen produced a prominent peak at m/z 577 in the positive ion polarity, ostensibly the protonated ethylene terephthalate trimer ion. The same m/z 577 peak was observed in spectra of the heat-treated PET films, albeit at lower integrated intensity. A decade later, Reichlmaier et al. in 1995 interrogated various heat-treated films of PET with time-of-flight SIMS (TOF-SIMS) imaging and observed that an m/z 577 feature in the positive ion polarity was

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localized to small domains on the surface. This early MS imaging analysis did not have the benefit of direct molecular identification, so the composition of the peak at m/z 577 was again reasoned, based on the work of Briggs, to be the protonated ethylene terephthalate trimer.

In this work, we have deployed a new method of tandem MS imaging for molecular identification at high resolving power. We demonstrate high lateral resolution imaging of the thermally induced surface precipitates concurrent with identification of the m/z 577 peak as ethylene terephthalate trimer. We observe that the ethylene terephthalate trimer signal emanates predominantly from the surface precipitates and that sodium, which evolves from the bulk to the surface during heat treatment, is situated outside the ethylene terephthalate precipitates.

MATERIALS AND METHODS

Films of PET manufactured from terephthalic acid (ICI plc, Middlesbrough, England) were utilized for heat treatment. Samples measuring $\sim 3\text{ cm} \times 3\text{ cm} \times 300\text{ }\mu\text{m}$ -thick were placed on a hot plate in a laboratory ambient atmosphere at $170\text{--}200^\circ\text{C}$ for $\sim 2\text{ h}$ as described by Reichlmeier et al. in 1995. The samples were introduced to vacuum for analysis ~ 1 week following heat treatment. The TOF-SIMS parallel imaging MS/MS analysis was performed using the TOF-TOF tandem MS on a PHI *nanoTOF* II instrument (Physical Electronics, Chanhassen, MN, USA) equipped with a 30 kV liquid metal ion gun (Larson et al., 2015; Fisher et al., 2016a, 2016b). The samples were interrogated by a mass pure Bi_3^{3+} cluster ion beam having a dc current of 6 nA. Each 32 ns pulse of the Bi_3^+ primary ion beam was digitally raster-scanned across 256×256 pixels of the $40 \times 40\text{ }\mu\text{m}$ analytical field-of-view (FOV). The primary ion dose density of $4.82 \times 10^{12}\text{ Bi}_3^+/\text{cm}^2$ that was used to generate the MS imaging data was below the static limit, and the total analysis time was 13 min. The MS^1 and MS^2 data were collected simultaneously and synchronously for each primary ion pulse delivered to the digitally raster-scanned image pixels, i.e., one primary ion pulse triggers one parallel cycle of the MS^1 and MS^2 . The images and spectra reported here were produced retrospectively from the raw data file using PHI SmartSoft-TOF and PHI TOF-DR software (Physical Electronics).

The TOF-TOF imaging MS used for this analysis is tandem in time. That is to say, there are two TOF spectrometers that operate in parallel. The TOF spectrometers are triggered together at a typical frequency of 8,300 Hz when the primary ion pulses are delivered to the sample. The MS^1 data arises from the TRIPLE Ion Focusing Time-of-flight (TRIFT) spectrometer, and the MS^2 data arises from the linear TOF spectrometer. The MS^2 duty cycle is $52\text{ }\mu\text{s}$ and is completed within the $120\text{ }\mu\text{s}$ duty cycle of the MS^1 . Hence, the MS^1 and MS^2 data are collected synchronously and from precisely the same analytical volume interrogated by the primary ion beam. There is a focus of the secondary ions at the location of the precursor selector which is a product of the TRIFT's original imaging ion microscope design (Schueler, 1992). At this focal point in the TRIFT spectrometer, the secondary ions have reached almost complete

TOF separation. Monoisotopic (i.e., 1 Da) precursor selection is realized as a consequence of both the TOF mass separation and the spatial focusing.

RESULTS AND DISCUSSION

TOF-SIMS parallel imaging MS/MS analysis of heat-treated PET specimens was performed in the positive ion polarity, with a monoisotopic precursor selection window centered at m/z 577.13, to both observe the lateral distribution and to identify without ambiguity the composition of the surface precipitates. The high selectivity of the precursor ions has been demonstrated and recently reported (Fisher et al., 2016b). The design and operating characteristics of the TOF-SIMS parallel imaging MS/MS instrument is described fully elsewhere, including schematic diagrams that provide a conceptual understanding of the instrument construct and function (Fisher et al., 2016a, 2016b). The 1 Da precursor selection is smaller than the 4–10 Da window commonly used in other tandem MS designs. Therefore, interpretation of the resulting product ion spectrum is simplified and does not require extraordinary performance in mass resolution or mass accuracy (Satoh et al., 2011; Shimma et al., 2012). What is more, high-energy (i.e., keV) collision-induced dissociation (CID) provides an advantage over low-energy CID because it enables structural elucidation in addition to compositional identification.

The monoisotopic window of precursor ions in the TRIFT (MS^1) spectrometer are deflected at $\approx 1.5\text{ keV}$ into the activation cell of the linear TOF (MS^2) spectrometer while the remainder travel on to the MS^1 detector. Following fragmentation in the activation cell, the product ions and unfragmented precursor ions are bunched, postaccelerated, and travel on to the MS^2 detector. No MS^1 data are discarded in the acquisition of MS^2 data. This point is illustrated in

Figure 1. a: Mass spectrometry (MS^1) positive polarity precursor ion spectrum in the range of m/z 180–700. The precursor selector is de-energized. b: MS^1 positive polarity precursor ion spectrum in the range of m/z 180–700. The precursor selector, with a monoisotopic (i.e., 1 Da) window centered at m/z 577.13, is energized at 100% duty cycle such that it is pulsed at the same frequency as that of the analytical primary ion beam. The peaks are labeled based on the tandem MS identification as discussed in the text.

Figure 1 where the MS^1 spectra are displayed with and without precursor ion deflection into the activation cell. The percent duty cycle of the precursor selection is variable by the operator such that, if desired, a fractional portion of the precursor ions may be selected to remain in the MS^1 spectrum for the purposes of normalization or quantification. The preservation of MS^1 data provides an internal calibration of the MS^2 data and the need for an exogenous calibration reference is eliminated.

The MS^2 product ion spectrum of the m/z 577 precursor is provided in Figure 2 wherein the diagnostic product ions are labeled. In order of ascending mass-to-charge ratio, they are $C_7H_4O^+$ (m/z 104), $C_8H_5O_3^+$ (m/z 149), $C_{10}H_9O_4^+$ ($[M+H]^+$, m/z 193), $C_{17}H_{13}O_5^+$ (m/z 297), $C_{18}H_{13}O_7^+$ (m/z 341), $C_{20}H_{17}O_8^+$ ($[2M+H]^+$, m/z 385), $C_{28}H_{21}O_{11}^+$ (m/z 533), and $C_{30}H_{25}O_{12}^+$ ($[3M+H]^+$, m/z 577). The product ion spectrum

provides conclusive evidence that the m/z 577 precursor is the protonated quasi-molecular ion of ethylene terephthalate trimer, $[3M+H]^+$. The MS^2 mass resolution ($m/\Delta m$) is measured at full-width and half-maximum to be 1,652 at m/z 193 ($[M+H]^+$), 1,830 at m/z 385 ($[2M+H]^+$), and 2,240 at m/z 577 ($[3M+H]^+$). The mass deviation across all calibration peaks of the product ion spectrum is 4.67 mDa root mean square, and the mass accuracy at the precursor is 3.35 ppm. The MS^2 product ion spectrum provides an accompanying benefit in that it may be used for the identification of peaks observed in the MS^1 spectrum since they appear at the same mass-to-charge ratios.

The MS^1 images are shown in the top row of Figure 3 and the MS^2 images are shown in the bottom row of Figure 3. The images were collected wherein a primary ion pulse generates both MS^1 and MS^2 spectra at each digitally

Figure 2. The positive ion polarity CID product ion tandem mass spectrometry (MS^2) spectrum of the m/z 577 precursor arising from a heat-treated film of poly(ethylene terephthalate). The MS^2 spectrum represents a sum of all image pixels. Each of the diagnostic peaks are labeled.

Figure 3. a–c: Mass spectrometry (MS^1) total ion and ion-specific images. d–f: Tandem mass spectrometry (MS^2) total ion and product ion images arising from fragmentation of the m/z 577 precursor. The MS^1 and MS^2 images reveal that the $[3M+H]^+$ precursor (m/z 577) and the corresponding CID product ions emanate predominantly from the surface precipitates. The images are $40 \times 40 \mu m$; the scale markers are $10 \mu m$. All images are displayed on a linear scale. TIC, total ion current.

raster-scanned image pixel. Thus, in a single measurement, the information content from the specified analytical volume is maximized. The primary ion beam was operated in the unbunched mode (i.e., no electrodynamic time compression) during analysis to achieve the best lateral resolution; therefore, only unit mass resolution is realized in the MS¹ spectrum. The mass resolution of the MS¹ spectrum is defined by the time duration of the primary ion pulse(s) (Cotter, 1997). However, the mass resolution of MS² is decoupled from that of MS¹ because the MS² contains electrodynamic time compression and postacceleration optics following the CID cell. The mass resolving power in both MS¹ and MS² as a function of time compression of the primary ion beam has been discussed and illustrated by Fisher et al. (2016b). Without electrodynamic time compression, the 32 ns primary ion pulses produce flat-top “unit resolution” peaks at each nominal mass of the MS¹ spectrum. However, full mass resolution is attained in the MS² spectrum, independent of the mass resolution in the MS¹ spectrum, whereas high lateral resolution is achieved in both the MS¹ and the MS² images. This utilitarian feature allows unprecedented molecular identification at <200 nm feature resolution. By operating the TOF–TOF spectrometer in the product ion scan mode, one concurrently achieves separation of the matrix components by MS¹ imaging and targeted identification of matrix components by MS² imaging. If an isobaric interference happens to exist within the 1 Da precursor selection window, the interfering species are easily observed and identified in the product ion spectrum.

Taken together, the MS¹ and MS² images of Figure 3 reveal that the ethylene terephthalate trimer $[3M + H]^+$ ions at m/z 577 arise predominantly from the thermally precipitated surface features. Fragment ions of PET, such as $C_8H_5O_3^+$ (m/z 149) and $C_7H_4O^+$ (m/z 104), are observed in MS¹ to emanate from both the surface precipitates and the surrounding polymer. The $C_8H_5O_3^+$ and $C_7H_4O^+$ ions originating near the center of the FOV in MS¹ appear to be suppressed. The presence of alkali metals in high abundance is a known cause of molecular ion suppression (Piowar et al., 2009). The MS¹ images reveal that Na^+ (m/z 23) and K^+ (m/z 39) are co-localized with the dark regions observed in the $C_8H_5O_3^+$ and $C_7H_4O^+$ images, and so the presence of the alkali metals explains the depressed signal from the polymer matrix. This co-localization is demonstrated for Na^+ in the overlay image presented in Figure 4. In addition, the MS¹ ion yields are observed to be greater in the surface precipitates than in the surrounding polymer matrix. An increase in the molecular density, as would be the case for crystalline phases, most often produces an increase of the overall ion yield (Winograd & Garrison, 1991). We can therefore infer that the surface precipitates have a greater molecular density than the surrounding polymer.

In MS², the $C_8H_5O_3^+$ and $C_7H_4O^+$ ions are products of neutral loss from the $[3M + H]^+$ precursor ions. As the $[3M + H]^+$ precursor is highly localized to the surface crystals, the $C_8H_5O_3^+$ and $C_7H_4O^+$ products are also observed to be localized to the surface crystals. In addition, the MS¹ and MS² images may be used together to evaluate the lateral

Figure 4. False color overlay image (at right) of Na^+ (red), $[3M + H]^+$ (green), and $C_7H_4O^+$ (blue). The individual ion images are shown at left. The mass spectrometry (MS¹) and tandem mass spectrometry (MS²) data were collected simultaneously from the same analytical volume. The images are $40 \times 40 \mu m$; the scale marker is $10 \mu m$.

distribution of chemistry. The overlay image disclosed in Figure 4 reveals a high abundance of Na^+ in areas of the sample with low organic ion signals as mentioned and discussed in the previous paragraph. This phenomenon was mentioned briefly by Reichlmeier et al. (1995) who observed a trend of increased Na^+ abundance at the surface with increased duration of the thermal treatment. Owing to the greater spatial resolution of the present analysis, we can establish that the surface segregation of sodium occurs around the precipitates and not within the precipitates. Moreover, we can substantiate that the abundance of ethylene terephthalate trimer is much greater in the surface precipitates than in the surrounding polymer matrix. We have calculated this difference using the ethylene terephthalate trimer signal ($[3M + H]^+$, m/z 577) normalized to a polymer fragment ($C_7H_4O^+$, m/z 104), and we arrive at a value of 6.1 which agrees well with expectations based on the data produced by Briggs (1986).

In Figure 5, we reveal the measured lateral resolution (Δl) determined from a curve fit to a line scan of 4 pixel averaging width and using 80 and 20% bounds. The results of multiple line scans reveal MS¹ and MS² imaging at <200 nm lateral resolution. As an example, the line scan on the MS¹ image of $C_7H_4O^+$ reveals a resolution of 172 nm. Likewise, a line scan on the MS² image of $[3M + H]^+$ exhibits a resolution of 148 nm.

CONCLUSION

The new tandem MS imaging spectrometer provides enormous power to the surface characterization method of TOF-SIMS for discovery and failure analysis in fields of high-performance materials, polymers, biology, pathology,

Figure 5. **a:** Line scan measurement on the mass spectrometry (MS^1) image of $C_7H_4O^+$ (m/z 104). The measured lateral resolution (Δl) is 172 nm. **b:** Line scan measurement on the tandem mass spectrometry (MS^2) image of $[3M + H]^+$ (m/z 577). The measured lateral resolution (Δl) is 148 nm. In each case, an averaging of 4 pixels was used in the line scan. The images are $40 \times 40 \mu m$.

pharmaceuticals, food sciences, power generation and storage devices, and forensics, to name just a few disciplines. The high speed of the TOF-TOF spectrometer allows concurrent surface screening of matrix components by MS^1 imaging and targeted identification of matrix components by MS^2 imaging in just a few minutes. The pulse counting detectors of the MS^1 and the MS^2 provide great sensitivity for MS^1 and MS^2 imaging. Therefore, numerous tandem MS imaging analyses can be performed on a typical sample, which is an advantage for maximizing the useful data obtained from “precious” or one-of-a-kind samples. For the characterization of molecular moieties, the combination of monoisotopic precursor selection and kiloelectronvolt collisional activation literally propels the TOF-SIMS analyst from making an educated guess at molecular identification to achieving unequivocal molecular identification. In essence, molecular identification by the TOF-SIMS analyst has progressed from “I think” to “I know”.

We have employed TOF-SIMS parallel imaging MS/MS for unambiguous molecular identification of surface precipitates on heat-treated PET. The highest resolving power ever reported for tandem MS imaging has been demonstrated. High mass resolution is realized in MS^2 , whereas a practical lateral resolution of <200 nm is simultaneously achieved in both MS^1 and MS^2 imaging. Further, no MS^1 data are discarded in the execution of an MS^2 analysis. Hence, without the need for sample extractions, reference materials or applied calibration moieties, and in a single analysis on the order of 10 min, we have proven that the surface precipitates on heat-treated PET are comprised of ethylene terephthalate trimer.

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